Shenzhen Leadtek Electronics Co.,LTD

Reliability Test Report

Customer Name	/	Item	CTP+LCM	Model number	/
Experiment name	Low temperature storage	Quantity	5pcs	Date	19th/July/2022

Objective: To verify the low temperature storage experiment of LTK in small batch trial production.

Inspection before product experiment: the appearance and functional electrical properties of the test sample 5pcs are OK.

Experimental requirements:
1. Experimental parameters: -20℃, 96H;
2. Observe every 4H to see if the function and appearance are normal;
3. In the experiment, turn on the LCM and CTP for 96H;
4. After the experiment, stand at room temperature and humidity for 2H to test whether the function and appearance of the product are normal.

Experiment start time : 9 : 00, 19th/July/2022 | **Experiment end time** : 9 : 00, 22th/July/2022

Product test inspection:

Product serial number	Product name	Observation test results during the experimental period									
		4H	8H	12H	24H	36H	48H	60H	72H	96H	Conclusion
1	CTP+LCM	OK	OK	OK	OK	OK	OK	OK	OK	OK	Qualified
2	CTP+LCM	OK	OK	OK	OK	OK	OK	OK	OK	OK	Qualified
3	CTP+LCM	OK	OK	OK	OK	OK	OK	OK	OK	OK	Qualified
4	CTP+LCM	OK	OK	OK	OK	OK	OK	OK	OK	OK	Qualified
5	CTP+LCM	OK	OK	OK	OK	OK	OK	OK	OK	OK	Qualified

Final judgment result:
After the sample 5pcs has been subjected to the low temperature operation experiment for 96 hours, the inspection function and appearance are OK, and there is no abnormality.

Inspectors : **Audit** : **Approve** :